



DOCUMENT CHANGE REQUEST

DCR number 165 Changes required for: General

Originator: S Thacker

Date: 2005/03/28

Date sent: 2005/03/28

Organisation: ESA/ESTEC

Status: IMPLEMENTED

Title: Requirements for Lead Materials and Finishes for Components for Space Application

Number: 23500

Issue: 1

Other documents affected:

Page:

Para: 1, 2, 3, 3.1, 3.2, 3.3, 3.3.1, 3.3.2, 3.3.3, 3.3.4, 4.2, 4.3

Pages: 4, 5, 6, 7, 8, 9, 10

Paragraph:

Para: 1, 2, 3, 3.1, 3.2, 3.3, 3.3.1, 3.3.2, 3.3.3, 3.3.4, 4.2, 4.3

Pages: 4, 5, 6, 7, 8, 9, 10

Original wording:

Proposed wording:

The following minor editorial changes have been made:

Para 1, Scope amended to reference ECSS-Q-70-08

Para 2, amended and corrected to include the applicable & reference documents - including ESCC 22700 and ECSS-Q-70-08

Para 3.1, amended to include last 2 subparas of para 1.

"P.I.D." amended to be "PID"

Para 3.2,

List is put into tabular form.

abbreviated commas are deleted from Type D

"Nickel-Iron" is amended to be "Iron-Nickel" for Type H & I

Para 3.3,

List is put into tabular form.

- Type 2 - amend reference to be Note 3 (was para 3.3.1)

- Type 4 - amend referenced para to be 4.3(a) (was 3.3.6)

- Note 2 amend wording to reference "paragraph or note" with regard to the warning and delete the warning paragraph example.



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Para 3.3.1 to 3.3.4, amended to be part of the notes to Para 3.3 i.e. to be notes 3, 4, 5 & 6.

Para 3.3.1, 1st sentence amended to read " ... Type 2 gold plated final finish ... "

Para 3.3.4,
Table layout simplified including the row & column descriptions.

Para 4.2, replace "Qualifying Space Agency" with "ESCC Executive"

Para 4.3, amend main title to use the terms "De-golding" and application of final finish for type 4"
Amend para text to use the terms "De-golding" and "gold dissolution"

Para 4.3 c), note 4 - amend sentence to read "... may be exceeded" (was " ...will be exceeded")

Para 4.3 c), note 6 - delete reference to "Table 1(b) of"

.....
The following technical changes have been made:

- 1) Para 1 & 2, ECSS-Q-70-08 is referenced and replaces "PSS 01 708"
- 2) Para 3.3.4,
Entries for materials D, F, G, H, I with finish Type 2 amended to show "S" or "W" assembly methods
- 3) Para 4.3 a), amend temperatures to be 250 to 280 degC (was 220 to 280 degC)
- 4) Para 4.3 b), amend temperatures to be 210 to 260 degC (was 210 to 230 degC)

Justification:

Editorial Changes

Specification is brought in to line with the ESCC specification format. The editorial changes listed above are for the purposes of clarification, simplification, consistency and to reduce any duplicated or redundant text.

Technical Changes

1), 3), 4) - The specification is made consistent with the latest ECSS Space product assurance standard ECSS-Q-70-08 (which replaces PSS 01 708).

2) - There is a contradiction in Para 3.3 Type 2 subpara for Type 2 and Para 3.3.4.

Para 3.3 states that materials D, F, G, H, I require nickel underplating and hence D2, F2, G2, H2, I2 are permitted combinations, yet Para 3.3.4 indicates that these combinations re not applicable.

These combinations, especially D2, are called up in many ESCC Detail specifications and as such are considered acceptable combinations for soldering or welding (as for the other materials given in the table for finish type 2).

Attachments:

23500.pdf, null

Modifications:

N/A

Approval signature:

A handwritten signature in black ink, appearing to be a stylized name or set of initials, located in the signature field.

Date signed:

2005-03-28



Pages 1 to 11

REQUIREMENTS FOR LEAD MATERIALS AND FINISHES FOR COMPONENTS FOR SPACE APPLICATION

ESCC Basic Specification No. 23500

| | |
|-----------------|------------|
| Issue 2 Draft A | March 2005 |
|-----------------|------------|



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| DCR No. | CHANGE DESCRIPTION |
|---------|---|
| 165 | Specification up issued to incorporate editorial and technical changes per DCR. |



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1. SCOPE

This specification prescribes the materials and surface finishes to be used for component leads and terminals for Space application. The requirements specified herein are intended to ensure that such leads and terminals are compatible with differing Space assembly requirements but in particular with the manual assembly requirements of ECSS Standard ECSS-Q-70-08.

2. RELATED DOCUMENTS

2.1 APPLICABLE DOCUMENTS

The following documents are applicable to the extent specified herein:

| | |
|------------|---|
| ESCC 22700 | Requirements and Guidelines for the Process Identification Document (PID) |
|------------|---|

2.2 REFERENCE DOCUMENTS

| | |
|--------------|---|
| ECSS-Q-70-08 | The manual soldering of high-reliability electrical connections |
|--------------|---|

3. REQUIREMENTS

3.1 GENERAL

Except where otherwise stated, only approved materials and finishes as specified in this specification, shall be used on ESCC components.

The lead or terminal type and finish of a component shall be specified in its Detail Specification using the lead and terminal material letters and finish numbers specified herein, e.g. A3.

The component Manufacturer shall establish a procurement specification to be used for the procurement of leads and terminals or lead material. This specification shall adequately establish the lead or terminal composition and type of lead finish, if any. In the case where the leads or terminals are an inherent part of a component package, the procurement specification for the package shall include full details of the lead or terminal material and finish required. These specifications shall be referenced in, and form part of, the Process Identification Document (PID) prepared in accordance with ESCC Basic Specification No. 22700.

3.2 APPROVED LEAD AND TERMINAL MATERIALS

The following materials are specified for the manufacture of ESCC component leads and terminals:

| Type | Description |
|------|---|
| A | Copper (oxygen-free) electrolytic |
| B | Copper (electrolytic tough pitch) |
| C | Iron-Nickel Alloy, copper-clad (e.g. Dumet) |
| D | Iron-Nickel-Cobalt Alloy (e.g. Kovar, Nilo K or Silver) |
| E | Nickel |
| F | Iron-Nickel Alloy (Alloy 52) |
| G | Iron-Nickel Alloy (Alloy 42) |
| H | Copper-core, Iron-Nickel Alloy 52, Clad-ratio 3:1 |
| I | Copper-core, Iron-Nickel Alloy 52, Clad-ratio 1.7:1 |
| J | Iron-core, Copper-clad Wire CCFE 30 |
| K | Iron-core, Copper-clad Wire CCFE 70 |
| L | Steel, Copper-clad |
| M | Beryllium Copper |
| N | Phosphor Bronze |
| O | Silver of purity 98% or better |
| P | Copper Alloy > 97% Cu (Alloy K50 or K65) |
| Q | Copper-Tungsten Alloy (15% Cu, 85% W) |

NOTES:

The terminal material for chip carrier packages need not be from the above list and does not need to be specified in the Detail Specification.

3.3

FINAL FINISH

The final finish of leads and terminals shall conform to one of the following, as appropriate and as specified:

| Type | Description |
|------|---|
| 1 | No finish. To be supplied without external finish. This is permitted only for Types A, B, C, J, K, L and O. |
| 2 | Gold plating, electro-deposited. The gold plating shall be of the type which is 99.7% gold minimum. The thickness of the gold plating shall be 1.3µm minimum to 5.7µm maximum. Electrolytic nickel underplating is required for lead and terminal Types D, F, G, H and I in accordance with Note 3. |
| 3 | Tin-Lead plating. The tin-lead plating shall be in accordance with the best commercial practice and have a composition of 30 to 70% tin (remainder lead). The thickness shall be minimum 2.5µm to maximum 13µm. |
| 4 | Hot solder dip. The solder shall be composition Sn63 and the coating shall have a thickness of 2.5µm to 13µm. Hot solder dip may be used over final finish Type 2, 7, 8 or 12 gold plating, but prior to this the leads or terminals shall be de-golded using the procedure defined in Para. 4.3(a) of this document. |
| 5 | Nickel-plating, electro-deposited. The nickel-plating finish shall have a thickness of 1.3µm minimum to 3.8µm maximum. |
| 6 | Gold-plating, electro-deposited with Nickel and Copper underplating. The first layer to be applied shall be 10 to 14µm of electro-deposited copper. The second layer to be applied shall be 3 to 6µm of electro-deposited nickel. The final layer to be applied shall be Type 2 gold plating. |
| 7 | Gold plating, electro-deposited with electroless Nickel underplating. This shall have an underlayer of nickel, electroless deposited with a 2 to 4µm thickness. The final layer shall be gold plating with 99.7% gold minimum. The thickness of the gold plating shall be 0.7µm minimum to 5.7µm maximum. |
| 8 | Gold plating, electro-deposited with Nickel and Palladium underplating. The first layer to be applied shall be 1.75µm minimum of electro-deposited nickel. The second layer to be applied shall be 0.25µm minimum of electro-deposited palladium. The final layer shall be gold plating with 99.7% gold minimum. The thickness of the gold plating shall be 0.7µm minimum to 5.7µm maximum. |
| 9 | Hot solder dip with Nickel underplating. This shall have an underlayer of nickel, electroless deposited with a 2 to 5µm thickness. The final layer shall be hot solder dip in accordance with Type 4. |
| 10 | Silver plating, electro-deposited. The plating shall be of 98% minimum silver purity of thickness between 3.8 and 8.9µm. |
| 11 | Reflowed Tin-Lead plating, with Nickel and Silver underplating. The first layer to be applied shall be 2µm minimum of electro-deposited nickel. The second layer to be applied shall be 0.1µm minimum of electro-deposited silver. The final layer to be applied shall be reflowed electro-deposited tin-lead plating with a composition of 85 to 95% tin (remainder lead). The thickness of the tin-lead plating shall be 3µm minimum to 8µm maximum. |

| Type | Description |
|------|---|
| 12 | Gold plating, electro-deposited, with Nickel and Silver underplating. The first layer to be applied shall be 2µm minimum of electro-deposited nickel. The second layer to be applied shall be 0.1µm minimum of electro-deposited silver. The final layer shall be 99.7% minimum gold plating. The thickness of the gold plating shall be 0.7µm minimum to 5.7µm maximum. |
| 13 | Gold plating, electro-deposited, with Copper underplating. The first layer to be applied shall be 5µm minimum of copper. The final layer shall be 99.7% minimum gold plating. The thickness of the gold plating shall be 2.5µm minimum to 5.7µm maximum. |
| 14 | Gold plating, electro-deposited with electrolytic Nickel underplating. This shall have an underlayer of nickel, electro-deposited with 2 to 9µm thickness. The final layer shall be gold-plating with 99.7% gold minimum. The thickness of the gold-plating shall be 0.7µm minimum to 5.7µm maximum |
| 15 | Tin-lead plating, electro-deposited with Silver underplating. The first layer shall be a nominal 0.1µm of electro-deposited silver. The final layer to be applied shall be electro-deposited tin-lead plating with a composition of 85 to 95% tin. The thickness of the tin-lead plating shall be 5 to 10µm. |

NOTES:

1. The final finish on a lead or terminal shall commence within 0.2mm of the device body, glass or metal seal or the lower end of the lead frame brazed joint. For epoxy sealed devices, the final finish shall commence not more than 1.5mm from the encapsulant.

2. Tin-lead plated or solder-dipped lead and terminal finish may only be tested in normal atmosphere at $T_{amb} \leq +125^{\circ}C$. Where tests are performed at $T_{amb} > +125^{\circ}C$, a 100% inert atmosphere must be used and components which are so tested shall include a warning paragraph or note to this effect in Section 1 of the Detail Specification.

3. An underplating of nickel is required prior to the Type 2 gold-plated final finish on leads or terminals of Type D, F, G, H and I.
The thickness of leads and terminals procured with underplating shall be specified in the Manufacturer's procurement specification. When the underplating is performed by the Manufacturer, or his Sub-contractor, the underplating thickness shall be specified in his/the Subcontractor's process specification. The thickness of nickel shall be:
 - (a) 0.5µm minimum to 3µm maximum.
 - (b) 1.3µm minimum to 3.8µm maximum.

4. All plating, whether for final finish or underplating, shall be deposited in such a manner that the plating is applied on clean, non-oxidized metal surfaces. The overall plating(s) shall be ductile such that when a plated lead or terminal is bent over a radius equal to twice the total lead or terminal thickness, there shall be no cracking and/or delamination of the plating layer visible at a magnification of X8.
All electroless-nickel plating shall have a bend test performed, on a sample basis, as part of the final inspection to ensure that this plating is sufficiently ductile as to avoid cracking or delamination during later operations when stress relief bends are being performed. The inside radius of the bend shall be equal to the lead or terminal diameter or thickness.

5. Pure Tin finish with more than 98% tin purity is not acceptable due to the possibility of whisker

growth and transformation to grey tin powder at low temperature.

6. Combinations of material and finish types together with the appropriate assembly methods are as follows:

| Material Type | Finish Type | | | | | | | | | | | | | | |
|---------------|-------------|----|---|---|----|----|----|----|---|----|----|----|----|----|----|
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 |
| A | W | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | SW | SW | - |
| B | W | - | S | S | SW | SW | SW | SW | S | SW | S | SW | SW | SW | - |
| C | W | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | SW | SW | - |
| D | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | - | SW | - |
| E | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | SW | SW | - |
| F | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | - | SW | - |
| G | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | - | SW | - |
| H | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | - | SW | - |
| I | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | - | SW | - |
| J | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | SW | SW | - |
| K | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | SW | SW | - |
| L | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | SW | SW | - |
| M | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | SW | SW | - |
| N | - | SW | S | S | SW | SW | SW | SW | S | SW | S | SW | SW | SW | - |
| O | SW | - | - | S | - | - | - | - | - | - | - | - | - | - | - |
| P | - | - | - | - | - | - | - | - | - | - | - | - | - | - | S |
| Q | - | - | - | - | - | - | - | - | - | - | - | - | - | S | - |

Legend: S = Solder, W = Weld.

4. ADDITIONAL REQUIREMENTS

4.1 CONDUCTIVE EPOXIES

Conductive epoxies will be considered for use as terminations on a case-by-case basis.

4.2 SUBSTITUTION OF LEAD OR TERMINAL TYPES

Substitution of any type of lead or terminal for the existing leads or terminals on an ESCC qualified component shall not take place without prior determination of the effect of such substitution on the component quality and reliability.

The approval of the ESCC Executive must always be obtained before any such substitution is implemented.

4.3 DE-GOLDING AND APPLICATION OF FINAL FINISH FOR TYPE 4

When a Type 4 finish is specified and is produced from a lead or terminal which was initially gold-plated, the gold shall be removed and the final finish applied using the following procedure:

(a) De-golding

The leads or terminals shall be dipped in a tin-lead solder bath (Bath 1), held at + 250 °C to +280 °C for 2 to 3 seconds. Regular analysis of the solder in this bath shall be made or, alternatively, the solder within the bath shall be regularly replaced, and the gold shall not exceed 1% by weight.

Prior to dipping, the molten surface of the bath shall be freshly skimmed to remove surface impurities such as oxides and the components' leads or terminals shall be lightly fluxed with a pure rosin flux which shall be removed afterwards using a cleaning solvent.

(b) Final Finish

After gold dissolution in Bath 1, the leads or terminals shall be pretinned in a second solder bath (Bath 2), held at +210 °C to 260 °C, for a minimum of 2 to a maximum of 8 seconds (the recommended immersion period is 3 to 4 seconds).

As for (a), the solder shall be regularly analysed or replaced ensuring that it is not contaminated with copper in excess of 0.25% by weight, nor with gold in excess of 0.2%, with the total of gold plus copper not exceeding 0.3%.

Contamination of Bath 2 with zinc, aluminium or iron shall also be carefully avoided. The fluxing of the lead or terminal, using pure rosin flux, and the skimming of the molten surface prior to dipping shall be as for (a).

In instances of poor solderability, activated fluxes may be used, but these shall be immediately cleaned off after dipping, using an acceptable solvent (see Note 5).

Withdrawal of component leads or terminals from Bath 2 shall be slow and vertical, without pauses, resulting in a solder-coat of more than 2µm

The cross-sectional area of the leads or terminals shall not be reduced by dissolution into the molten solder.

When the solder produces a dull, frosty or granular appearance on the work, the bath shall be removed from use.

(c) Notes Applicable to both (a) and (b)

1. In no instances shall a component body or its glass meniscus be immersed in, or become wetted by, liquid solder. The limited tinning distance, where specified, shall not be exceeded.
2. On no account shall the final finishing be carried out in the solder which has been used for de-golding.
3. On no account shall the absolute maximum soldering rating of the component be exceeded.
4. Suitable thermal shunts shall be used for the de-golding and pre-tinning of temperature-sensitive components or whenever it is not certain whether the maximum temperature rating may be exceeded.
5. The following solvents may be used for flux removal:
 - (a) Ethyl alcohol, 99.5 or 95% pure by volume
 - (b) Isopropyl alcohol, 99% pure.
 - (c) Trichlorotrifluorethane, clear, 99.8% pure.
 - (d) Any mixture of the above.
 - (e) Deionised water at 40 °C maximum may be used for certain fluxes. Items shall be thoroughly dried directly after the use of deionised water.
6. The final finish shall be evident and continuous on all leads and terminals and, as a minimum, shall extend downwards from the seating plane.
For components which do not have a seating plane, the final finish shall extend downwards



from the minimum soldering distance specified in the Detail Specification.